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IS 8271 (Part 5/Sec 17): 1990

भारतीय मानक

आवृति नियंत्रण और चयन में प्रयुक्त क्वार्टज् क्रिस्टल इकाइयाँ – विशिष्टि

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> > Indian Standard

QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION — SPECIFICATION

PART 5 SERIES CX FOR OSCILLATORS
Section 17 Quartz Crystal Unit Type CX-17

UDC 621:373:5

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BUREAU OF INDIAN STANDARDS MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG NEW DELHI 110002 Piezoelectric Devices for Frequency Control and Selection Sectional Committee, LTD 12

FOREWORD

This Indian Standard (Part 5/Sec 17) was adopted by the Bureau of Indian Standards on 17 May 1990, after the draft finalized by the Piezoelectric Devices for Frequency Control and Selection Sectional Committee had been approved by the Electronics and Telecommunication Division Council.

This standard shall be read in conjunction with IS 8271 (Part 1): 1981 'Specification for quartz crystal units used for frequency control and selection: Part 1 General requirements and tests (first revision)'.

This standard is based on JSS 50910 (1971) 'Detail specification for crystal unit, quartz, styles QC 36, QC 37, QC 38, QC 39 and QC 42', issued by the Directorate of Standardization, Ministry of Defence, India. The type of quartz crystal unit covered in this standard is equivalent to style QC 39 of JSS 50910 (1971).

For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated, expressing the result of a test or analysis, shall be rounded off in accordance with IS 2: 1960 'Rules for rounding off numerical values (revised)'. The number of significant places retained in the rounded off values should be the same as that of the specified value in this standard.

Indian Standard

QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION — SPECIFICATION

PART 5 SERIES CX FOR OSCILLATORS

Section 17 Quartz Crystal Unit Type CX-17

1 SCOPE

1.1 This standard specifies detail requirements, for the characteristics of quartz crystal unit, Type CX-17 used for frequency control and selection in oscillators.

2 REFERENCES

2.1 The following Indian Standards have been referred to in this standard:

IS No.

Title

4570 (Part 6): 1984 Specification for crystal unit holders: Part 6 Metal, solder seal, two-pin, crystal unit holder

Type CX

8271 (Part 1): 1981

Specification for quartz crystal units used for frequency control and selection: Part 1 General requirements and tests (first revision)

3 OUTLINE AND DIMENSIONS

3.1 Holder outline shall conform to Type CX [see IS 4570 (Part 6): 1984].

4 MARKING

4.1 See 8 of IS 8271 (Part 1): 1981.

5 CONSTRUCTION AND WORKMANSHIP

5.1 See 7 of IS 8271 (Part 1): 1981.

6 TEST SCHEDULE AND DETAIL REQUIREMENTS

6.1 General Conditions for Test

See 9.2 of IS 8271 (Part 1): 1981.

6.2 Test Schedule

The sequence and grouping of type, routine and acceptance tests shall be in accordance with 9.1 of IS 8271 (Part 1): 1981.

6.3 Detail Requirements

The detail requirements applicable to this particular type of crystal unit shall be as specified in Table 1.

Table 1 Detail Requirements of Quartz Crystal Unit Type CX-17

(Clause 6.3)

	(0.0000	
Sl No	. Characteristics	Requirements
(1)	(2)	(3)
i)	Type of holder	CX (see 3)
ii)	Frequency range	50 to 125 MHz
iii)		
	a) Operating temperature range	\pm 20 ppm
	b) Room temperature	\pm 80 ppm
	Frequency stability	± 5 ppm
	Load capacitance	Infinity
	Mode of oscillation	Fifth mechanical overtone
vii)		$85^{\circ}\text{C} \pm 1^{\circ}\text{C}$
viii)	Temperature range:	
	a) Operating	80°C to 90°C
	b) Operable	-55° C to $+80^{\circ}$ C
	Test set, calibration values and rated drive level	See Table 2
x)	Capacitance shunt	7 pF, Max
xi)	Resonance resistance:	70 1 ×4
	a) 50 to 100 MHz	50 ohms, Max
! ! \	b) 100 to 125 MHz	60 ohms, Max
xii)		
	(Part 1): 1981]:	1 <i>E</i>
	a) Frequency change permitted b) Resonance resistance change permitted	± 5 ppm
xiii)		± 10 percent
XIII)	IS 8271 (Part 1): 1981]:	
	a) Frequency change permitted	± 5 ppm
	b) Resonance resistance change permitted	± 3 ppm ± 10 percent
xiv)		I to beteem
AIV)	Frequency change permitted	± 5 ppm
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Table 2 Test Set, Calibration Values and Rated Drive Level
[Table 1 (ix)]

Frequency Range	Calibration Values		Rated Drive	Test Set
	Resistance	Resistor Voltage Drop	Level	
(1)	(2)	(3)	(4)	(5)
MHz	ohms	volt	mW	
Up to 100	60	0•24	1·0 ± 0·2	TS-683/TSM
Above 100	60	0.24	1.0 ± 0.24	AN/TSM-15

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